Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/759,640	CHAIKEN ET AL.	
Examiner	Art Unit	
Eric Chang	2116	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	ERFERENC	RENCE SEARCHED	
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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EAST USPAT/PGPUB EPO/JPO	3/5/2007	EC	
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